

Notice of References Cited

Application/Control No.

10/598,230

Applicant(s)/Patent Under
Reexamination
HEKSTRA ET AL.

Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0036782 A1	02-2004	Knapp, Verna	348/239
	B	US-			
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FOREIGN PATENT DOCUMENTS

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